

# Advance Technical Information

# Standard Power MOSFET

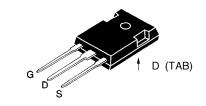
**IXTH 16P20** 

P-Channel Enhancement Mode Avalanche Rated  $V_{DSS} = -200 \text{ V}$   $I_{D25} = -16 \text{ A}$   $R_{DS(on)} = 0.22 \Omega$ 



Symbol	<b>Test Conditions</b>	Maximum	<b>Maximum Ratings</b>		
$\overline{V}_{DSS}$	T <sub>J</sub> = 25°C to 150°C	-200	V		
$V_{DGR}$	$T_J = 25^{\circ}C$ to 150°C; $R_{GS} = 1 \text{ M}\Omega$	-200	V		
$\overline{V_{gs}}$	Continuous	±20	V		
$\mathbf{V}_{GSM}$	Transient	±30	V		
I <sub>D25</sub>	T <sub>C</sub> = 25°C	-16	A		
I <sub>DM</sub>	$T_{_{\rm C}}$ = 25°C, pulse width limited by $T_{_{\rm J}}$	-64	Α		
I <sub>AR</sub>	$T_{c} = 25^{\circ}C$	-16	Α		
E <sub>AR</sub>	T <sub>C</sub> = 25°C	30	mJ		
$\overline{\mathbf{P}_{\scriptscriptstyle \mathrm{D}}}$	T <sub>C</sub> = 25°C	180	W		
T <sub>J</sub>		-55 +150	°C		
T <sub>JM</sub>		150	°C		
T <sub>stg</sub>		-55 +150	°C		
T <sub>L</sub>	Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s	300	°C		
$\mathbf{M}_{d}$	Mounting torque	1.13/10	Nm/lb.in.		
Weight		6	g		

## **TO-247 AD**



G = Gate, D = Drain, S = Source, TAB = Drain

#### **Features**

- International standard package JEDEC TO-247 AD
- Low  $R_{DS (on)} HDMOS^{TM} process$
- · Rugged polysilicon gate cell structure
- Unclamped Inductive Switching (UIS) rated
- Low package inductance (<5 nH)
  - easy to drive and to protect

Symbol	<b>Test Conditions</b>	(T <sub>J</sub> = 25°C, 1		istic Va se speci max.	
V <sub>DSS</sub>	$V_{GS}$ = 0 V, $I_{D}$ = -250 $\mu$ A		-200		V
V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$		-3.0	-5.0	V
I <sub>GSS</sub>	$V_{GS} = \pm 20 \ V_{DC}, \ V_{DS} = 0$			±100	nA
I <sub>DSS</sub>	$V_{DS} = 0.8  V_{DSS}$ $V_{GS} = 0  V$	T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C		-25 -1	μA mA
R <sub>DS(on)</sub>	$V_{GS} = -10 \text{ V}, I_{D} = 0.5 I_{D25}$			0.22	Ω

### **Applications**

- · High side switching
- Push-pull amplifiers
- DC choppers
- Automatic test equipment

## Advantages

- Easy to mount with 1 screw (isolated mounting screw hole)
- Space savings
- · High power density



Symbol		Characteristic Values so otherwise specified)		
	min.	typ.	max.	
$g_{fs}$	$V_{DS} = -10 \text{ V}; I_{D} = I_{D25}, \text{ pulse test}$ 6	10	S	
C <sub>iss</sub>	)	2800	pF	
C <sub>oss</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = -25 \text{ V}, f = 1 \text{ MHz}$	550	pF	
$\mathbf{C}_{rss}$	J	240	pF	
t <sub>d(on)</sub>	)	33	ns	
t <sub>r</sub>	$V_{GS} = -10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_{D} = 0.5 I_{D25}$	26	ns	
$\mathbf{t}_{d(off)}$	$R_{\rm G} = 4.7 \Omega \text{ (External)}$	65	ns	
t,	)	25	ns	
Q <sub>g(on)</sub>		95	nC	
$\mathbf{Q}_{gs}$	$V_{GS} = -10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_{D} = 0.5 I_{D25}$	27	nC	
$\mathbf{Q}_{gd}$	J	40	nC	
R <sub>thJC</sub>			0.65 K/W	
R <sub>thCS</sub>		0.25	K/W	

#### Terminals: 1 - Gate 2 - Drain Tab - Drain 3 - Source Dim. Millimeter Inches Max. Min. Max. Min. 4.7 5.3 .185 .209 Α $A_1$ 2.2 2.54 .087 .102 2.2 2.6 .059 .098 1.0 .040 .055 b 1.4 b, 1.65 2.13 .065 .084 b, 2.87 3.12 .113 .123 C D .016 .031 20.80 21.46 .819 .845 Е 15.75 16.26 .610 .640 е 5.20 5.72 0.205 0.225 .800 19.81 20.32 .780 L1 4.50 .177 ØP 3.55 3.65 .144 .140

TO-247 AD Outline

Q

R

S

5.89

4.32

6.15 BSC

6.40

5.49

0.232 0.252

242 BSC

.216

.170

# Source-Drain Diode

Symbol	Test Conditions	min.	typ.	max.	
I <sub>s</sub>	V <sub>GS</sub> = 0			-16	Α
I <sub>SM</sub>	Repetitive; pulse width limited by $T_{_{\rm JM}}$			-64	Α
V <sub>SD</sub>	$I_F = I_S$ , $V_{GS} = 0$ V, Pulse test, $t \le 300$ $\mu s$ , duty cycle $d \le 2$ %			-3	V
t <sub>rr</sub>	$I_{F} = I_{S}$ , di/dt = 100 A/ $\mu$ s, $V_{R} = -50 \text{ V}$		250		ns